SEDRA/SMITH Microelectronic Circuits SEVENTH EDITION

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Chapter 3

Semiconductors

Introduction

- 3.1 Intrinsic Semiconductors
- 3.2 Doped Semiconductors
- 3.3 Current Flow in Semiconductors
- 3.4 The pn Junction with an Applied Voltage
- 3.4.1 Qualitative Description of Junction Operation
- 3.4.2 The Current-Voltage Relationship of the Junction
- 3.4.3 Reverse Breakdown

3.5 Capacitive Effects in the pn Junction

2 ways charge can be stored in pn junction.

- 1. charge in depletion region (more visible when reverse bias)
- 2. minority charge in n and p material (more visible when forward bias)
 - concentration profile by injecting to n-dope
 - " to p-dope

3.5.1 Depletion or Junction Capacitance

Assumption: pn junction reversed bias with V_R , charge on either side of junction:

$$Q_J = A\sqrt{2\epsilon_s q \frac{N_A N_D}{N_A + N_D} (V_0 + V_R)} = \alpha \sqrt{(V_0 + V_R)}$$
(3.1)

We denote α as $A\sqrt{2\epsilon_sq\frac{N_AN_D}{N_A+N_D}}$ and observe that $Q_J\not\subset V_R$ (also not linearly related)

 \bullet Hard to define capacitance that accounts for changing Q_J when V_R changes

Assumption: junction operates as a point Q and define

$$C_j = \frac{dQ_J}{dV_r} \bigg|_{V_R = V_Q} \tag{3.2}$$

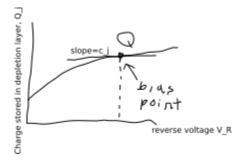


Figure 3.1: The charge stored on either side of the depletion layer as a function of the reverse voltage V_R

Note:-

The definition of capacitance

$$q = CV \implies C = q/V = \frac{\Delta q}{\Delta V}$$

- Equation 3.2 useful in electronic cct design
- This equation used in this book frequently
- Called the "incremental-capacitance approach"

Combining equations 3.2 with 3.1 we obtain:

$$C_j = \frac{\alpha}{2\sqrt{V_0 + V_R}} \tag{3.3}$$

We observe that C_j at reverse bias $(V_R=0)$ is $C_{j0}=\frac{\alpha}{2\sqrt{V_0}}$, so we can write C_j as

$$C_j = \frac{C_{j0}}{\sqrt{1 + \frac{V_R}{V_0}}} \tag{3.4}$$

Substituting for α , we obtain:

$$C_{j} = A\sqrt{\left(\frac{\epsilon_{s}q}{2}\right)\left(\frac{N_{A}N_{D}}{N_{A} + N_{D}}\right)\left(\frac{1}{V_{0}}\right)}$$
(3.5)

Before leaving concept of junction capacitance, we introduce

Definition 3.5.1: Terms

Abrupt junction pn junction, doping concentration changes abruptly at junction boundary (this is deliberately done)

Graded junction: pn junction, carrier concentration changes gradually from one side to another. Then C_i becomes:

$$C_j = \frac{C_{j0}}{\left(1 + \frac{V_R}{V_0}\right)^m}$$

where m is the **Grading coefficient**

Note:-

- m ranges from 1/3 to 1/2
- m depends on manner in which concentration changes from p to n side

Question 1: Exercise 3.14

For the $pn \dots cm^2$.

Solution: Solution

3.5.2 Diffusion Capacitance